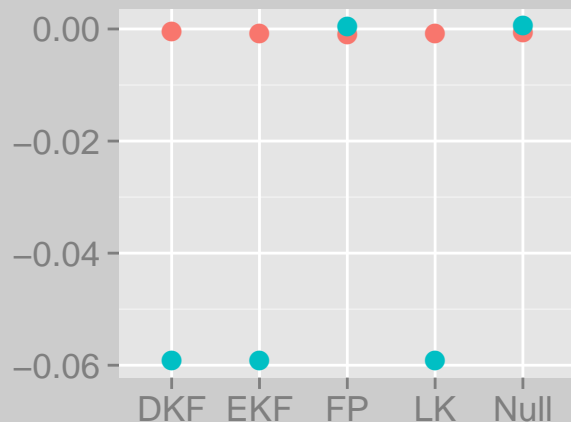
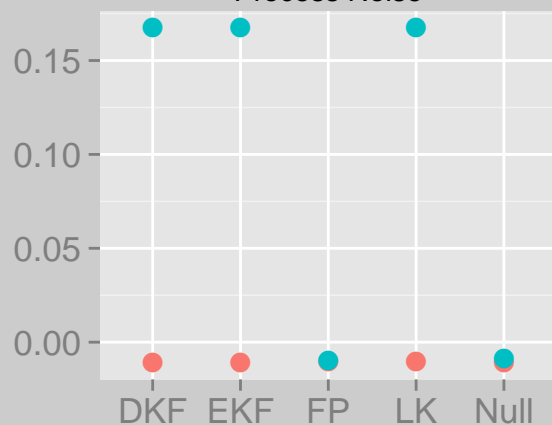


## Bias

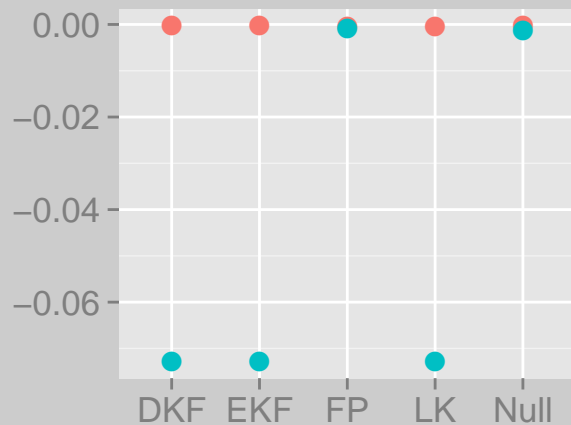
Measurement



Process Noise



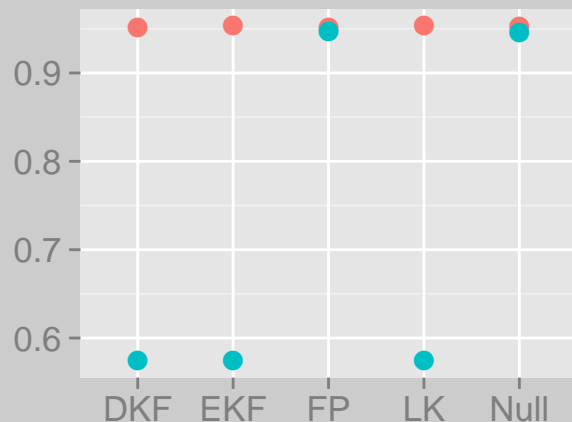
Time Series



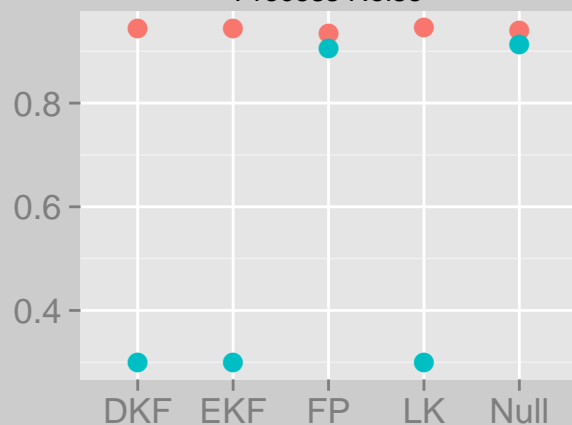
FittedIC

## Coverage Rates

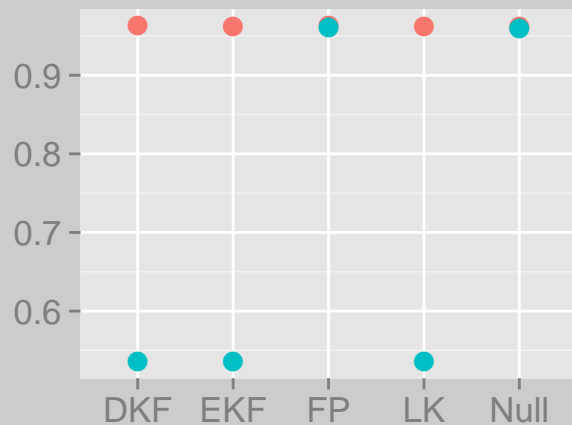
Measurement



Process Noise



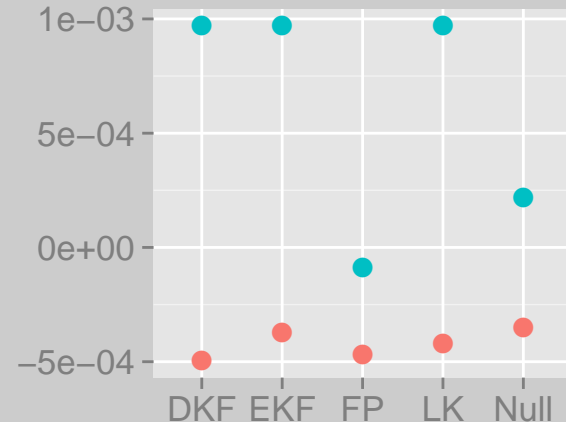
Time Series



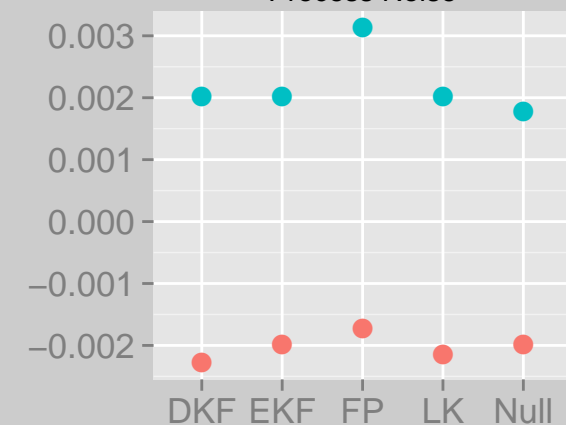
FittedIC

## SD - SE

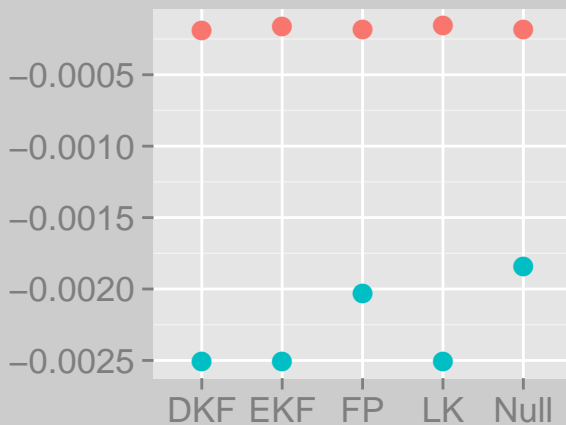
Measurement



Process Noise



Time Series



FittedIC